# **Power MOSFET** 60 V, 61 A, 12 m $\Omega$ , Single N–Channel

### Features

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These are Pb–Free Devices

### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

	10		,		-	
Parar	neter		Symbol	Value	Unit	
Drain-to-Source Voltage			V <sub>DSS</sub>	60	V	
Gate-to-Source Voltage	Э		V <sub>GS</sub>	±20	V	
Continuous Drain Current $R_{\Psi J-mb}$ (Notes 1,		T <sub>mb</sub> = 25°C	۱ <sub>D</sub>	61	A	
2, 3, 4)	Steady	$T_{mb} = 100^{\circ}C$		43		
Power Dissipation	State	T <sub>mb</sub> = 25°C	PD	107	W	
R <sub>ΨJ-mb</sub> (Notes 1, 2, 3)		T <sub>mb</sub> = 100°C		54		
Continuous Drain Current $R_{\theta,IA}$ (Notes 1, 3,		$T_A = 25^{\circ}C$	Ι <sub>D</sub>	11.2	A	
4)	Steady	T <sub>A</sub> = 100°C		8.0		
Power Dissipation	State	T <sub>A</sub> = 25°C	PD	3.7	W	
$R_{\theta JA}$ (Notes 1 & 3)		T <sub>A</sub> = 100°C		1.8		
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I <sub>DM</sub>	247	Α	
Current Limited by Package $T_A = 25^{\circ}C$ (Note 4)		I <sub>DmaxPkg</sub>	80	A		
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C		
Source Current (Body Diode)		I <sub>S</sub>	60	Α		
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 10 V, $I_{L(pk)}$ = 31 A, L = 0.1 mH, R <sub>G</sub> = 25 $\Omega$ )			E <sub>AS</sub>	48	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\Psi J-mb}$	1.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	41	

 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi ( $\Psi$ ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.

3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

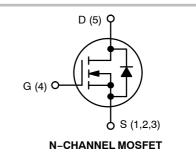
4. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

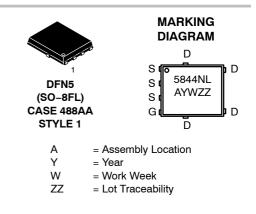


# **ON Semiconductor®**

### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
60 V	12 m $\Omega$ @ 10 V	61 A
00 v	16 mΩ @ 4.5 V	ULA





# ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTMFS5844NLT1G	DFN5 (Pb-Free)	1500/Tape & Reel
NVMFS5844NLT1G	DFN5 (Pb-Free)	1500/Tape & Reel
NVMFS5844NLT3G	DFN5 (Pb-Free)	5000/Tape & Reel

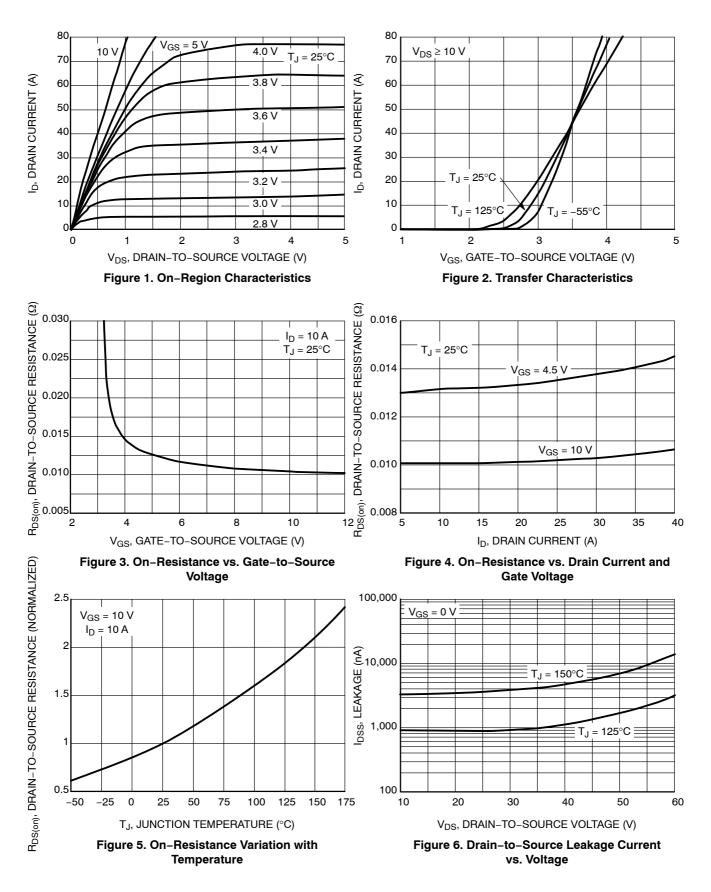
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

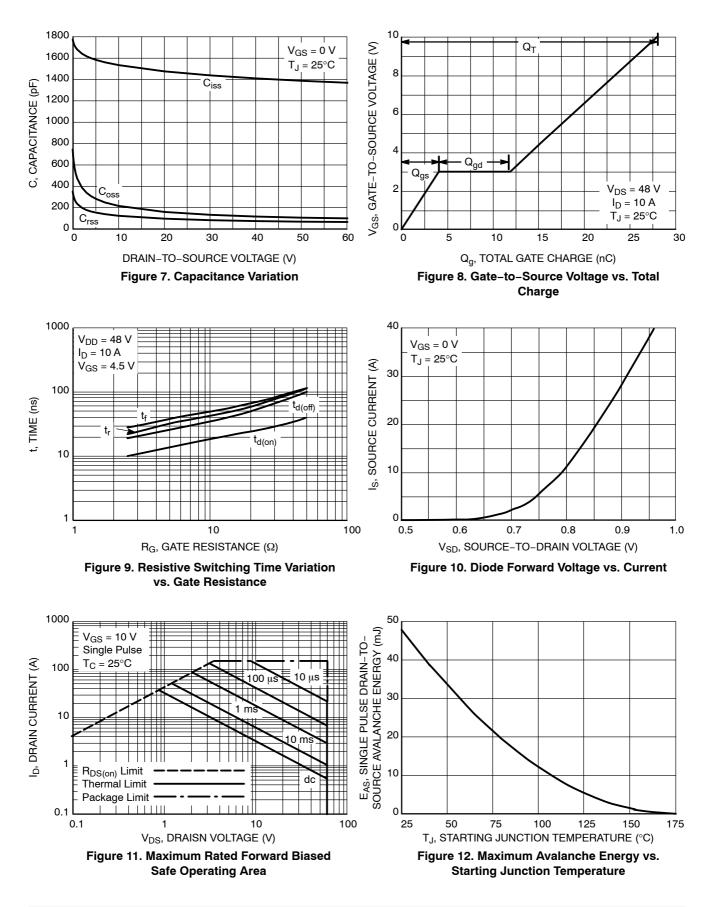
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> =	= 250 μA	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				57		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			1	μΑ
		$V_{\rm DS} = 60 \text{ V}$	T <sub>J</sub> = 125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V				±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μA	1.5		2.3	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A		10.2	12	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 10 A		13	16	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 10 A			27		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			1460		pF
Output Capacitance	C <sub>OSS</sub>				150		
Reverse Transfer Capacitance	C <sub>RSS</sub>				96		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 4	18 V; I <sub>D</sub> = 10 A		30		-
Total Gate Charge	Q <sub>G(TOT)</sub>				15		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 48 V; I <sub>D</sub> = 10 A			1.0		nC
Gate-to-Source Charge	Q <sub>GS</sub>				4.0		
Gate-to-Drain Charge	Q <sub>GD</sub>				8.0		
Plateau Voltage	V <sub>GP</sub>				3.0		V
Gate Resistance	R <sub>G</sub>				0.62		Ω
SWITCHING CHARACTERISTICS (Note 6)							
Turn-On Delay Time	t <sub>d(ON)</sub>				12		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>E</sub>	ns = 48 V.		25		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 10 \text{ A}, \text{ R}_G = 2.5 \Omega$			20		- ns
Fall Time	t <sub>f</sub>				10		
DRAIN-SOURCE DIODE CHARACTERISTIC	s				1	1	
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A	$T_J = 25^{\circ}C$		0.79	1.2	v
			T <sub>J</sub> = 125°C		0.65		
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/µs, I <sub>S</sub> = 10 A			19		ns
Charge Time	t <sub>a</sub>				13		
Discharge Time	t <sub>b</sub>				6.0		
Reverse Recovery Charge	Q <sub>RR</sub>				15		nC

Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**



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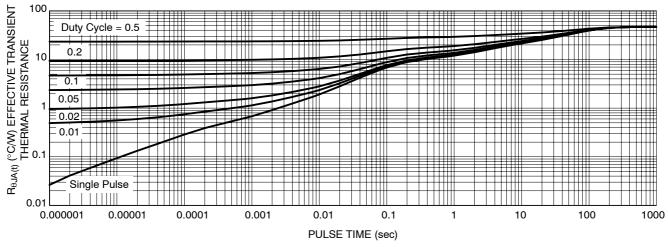
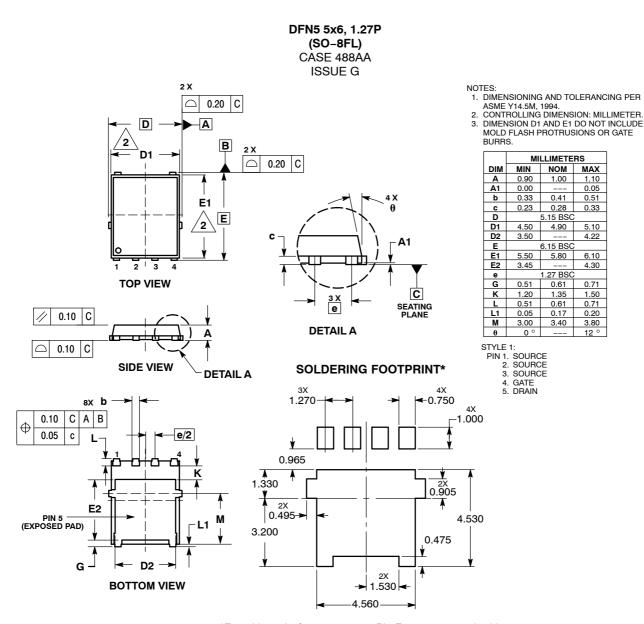


Figure 13. Thermal Response

### PACKAGE DIMENSIONS



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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